

Notice of References Cited	Application/Control No. 10/678,043		Applicant(s)/Patent Under Reexamination MCINTOSH ET AL.	
	Examiner JOHN HEFFINGTON		Art Unit 2179	Page 1 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,157,782 A	10-1992	Tuttle et al.	714/45
*	B	US-5,325,377 A	06-1994	Tuttle, Myron R.	714/819
*	C	US-5,335,342 A	08-1994	Pope et al.	714/38
*	D	US-5,499,108 A	03-1996	Cotte et al.	358/400
*	E	US-5,591,956 A	01-1997	Longacre et al.	235/462.1
*	F	US-5,604,509 A	02-1997	Moore et al.	345/2.1
*	G	US-5,637,851 A	06-1997	Swartz et al.	235/462.2
*	H	US-5,646,602 A	07-1997	Gertz et al.	340/825.25
*	I	US-5,732,212 A	03-1998	Perholtz et al.	709/224
*	J	US-5,739,809 A	04-1998	McLaughlin et al.	345/594
*	K	US-5,874,966 A	02-1999	Polimeni et al.	345/594
*	L	US-5,995,663 A	11-1999	Itsuzaki et al.	382/203
*	M	US-6,005,964 A	12-1999	Reid et al.	382/133

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/678,043		Applicant(s)/Patent Under Reexamination MCINTOSH ET AL.	
	Examiner JOHN HEFFINGTON		Art Unit 2179	Page 2 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,118,447 A	09-2000	Harel, Avraham	717/131
*	B	US-2001/0002697 A1	06-2001	Hiroi et al.	250/310
*	C	US-6,292,171 B1	09-2001	Fu et al.	345/156
*	D	US-2002/0039436 A1	04-2002	Alumot et al.	382/149
*	E	US-2002/0054104 A1	05-2002	BERCZIK et al.	345/764
*	F	US-2002/0099978 A1	07-2002	Kraffert, Mark J.	714/38
*	G	US-2002/0100014 A1	07-2002	Iborra et al.	717/104
*	H	US-2002/0111813 A1	08-2002	Capps, Stephan P.	705/1
*	I	US-2002/0101519 A1	08-2002	Myers, Jeffrey S.	348/232
*	J	US-2002/0141641 A1	10-2002	Zhu, Jie	382/170
*	K	US-2002/0152169 A1	10-2002	Dutta et al.	705/45
*	L	US-6,502,045 B1	12-2002	Biagiotti, William R.	702/66
*	M	US-2003/0020751 A1	01-2003	Safa et al.	345/760

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/678,043		Applicant(s)/Patent Under Reexamination MCINTOSH ET AL.	
	Examiner JOHN HEFFINGTON		Art Unit 2179	Page 3 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0012414 A1	01-2003	Luo, Huitao	382/118
*	B	US-2003/0026457 A1	02-2003	Nahum, Michael	382/106
*	C	US-2003/0056150 A1	03-2003	Dubovsky, David	714/38
*	D	US-2003/0053675 A1	03-2003	Kuwabara, Masayuki	382/145
*	E	US-2003/0058277 A1	03-2003	BOWMAN-AMUAH, MICHEL K.	345/765
*	F	US-2003/0066031 A1	04-2003	Laane, Lisa Ann	715/513
*	G	US-6,571,003 B1	05-2003	Hillebrand et al.	382/118
*	H	US-2003/0123733 A1	07-2003	Keskar et al.	382/187
*	I	US-2003/0153823 A1	08-2003	Geiser et al.	600/407
*	J	US-2003/0198385 A1	10-2003	Tanner et al.	382/195
*	K	US-2004/0076323 A1	04-2004	Fujii et al.	382/151
*	L	US-2004/0181754 A1	09-2004	Kremer et al.	715/526
*	M	US-2004/0201709 A1	10-2004	McIntyre et al.	348/211.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/678,043		Applicant(s)/Patent Under Reexamination MCINTOSH ET AL.	
	Examiner JOHN HEFFINGTON		Art Unit 2179	Page 4 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0008212 A1	01-2005	Ewing et al.	382/133
*	B	US-2005/0031165 A1	02-2005	Olson et al.	382/103
*	C	US-2005/0035877 A1	02-2005	Kim, Duk-Soo	340/870.02
*	D	US-2005/0082476 A1	04-2005	Hiroi et al.	250/310
*	E	US-6,907,546 B1	06-2005	Haswell et al.	714/38
*	F	US-6,904,389 B2	06-2005	Hornberger et al.	702/188
*	G	US-6,980,686 B2	12-2005	Kuwabara, Masayuki	382/145
*	H	US-7,046,848 B1	05-2006	Olcott, Peter L.	382/176
*	I	US-2006/0228040 A1	10-2006	Simon et al.	382/254
*	J	US-7,120,299 B2	10-2006	Keskar et al.	382/187
*	K	US-2007/0131877 A9	06-2007	Hiroi et al.	250/492.2
*	L	US-2007/0217687 A1	09-2007	Arima, Toshimichi	382/224
*	M	US-7,406,191 B2	07-2008	Fujii et al.	382/144

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/678,043		Applicant(s)/Patent Under Reexamination MCINTOSH ET AL.	
	Examiner JOHN HEFFINGTON		Art Unit 2179	Page 5 of 5

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2009/0052750 A1	02-2009	Steinberg et al.	382/118
*	B	US-2009/0087042 A1	04-2009	Steinberg et al.	382/118
*	C	US-2009/0148033 A1	06-2009	Alumot et al.	382/149
*	D	US-7,683,881 B2	03-2010	Sun et al.	345/156
*	E	US-2010/0197376 A1	08-2010	Kerr, Michael A.	463/17
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.